

<b>Search Notes</b>	<b>Application/Control No.</b>	<b>Applicant(s)/Patent Under Reexamination</b>
	10576154	MURAYAMA ET AL.
	<b>Examiner</b>	<b>Art Unit</b>
	Bomkamp, Eric A	2826

### SEARCHED

<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>
257	E33.058, E33.075	9-28-07	EB

### SEARCH NOTES

<b>Search Notes</b>	<b>Date</b>	<b>Examiner</b>
Text search in EAST. Search provided by Minh Tran. See attached	9-28-07	EB

### INTERFERENCE SEARCH

<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>